Digital Integrated Circuit Lecture 12 Delay

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GIST Lecture

Review of Previous Lecture

Lecture 11

- RC model
 - Effective resistance, *R*
 - -Gate capacitance and diffusion capacitances, C
 - -Scaling
 - -There appears a chain of R and C.

4.3 RC Delay Model

4.3. RC delay model (6)

- Example 4.4
 - -Estimate t_{pd} for a "unit" inverter (PMOS width:NMOS width=2:1 & minimum length) driving identical "unit" inverters.
 - Effective resistance is R. (Same for NMOS and PMOS)
 - -Capacitance is (3 + 3m)C. $t_{nd} = (3 + 3m)RC$

4.3. RC delay model (7)

- Example 4.5
 - -The driver is w times unit size.
 - The effective resistance is $\frac{R}{w}$ and the diffusion capacitance is wC.
 - Estimate t_{pd} .

$$t_{pd} = \left(3 + 3\frac{m}{w}\right)RC$$

$$t_{pd} = \left(3 + 3 - \frac{1}{w}\right)RC$$

$$- \text{With a fanout of } h = \frac{m}{w},$$

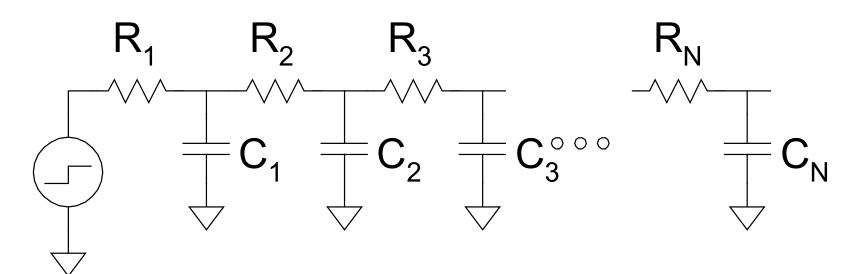
$$t_{pd} = (3 + 3h)RC$$

4.3. RC delay model (8)

- A chain of R and C
 - A simple single time constant approximation

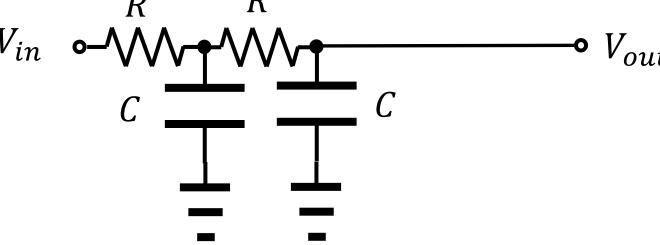
$$t_{pd} \approx \sum_{\text{nodes } i} R_{i-to-source} C_i$$

$$= R_1 C_1 + (R_1 + R_2) C_2 + ... + (R_1 + R_2 + ... + R_N) C_N$$



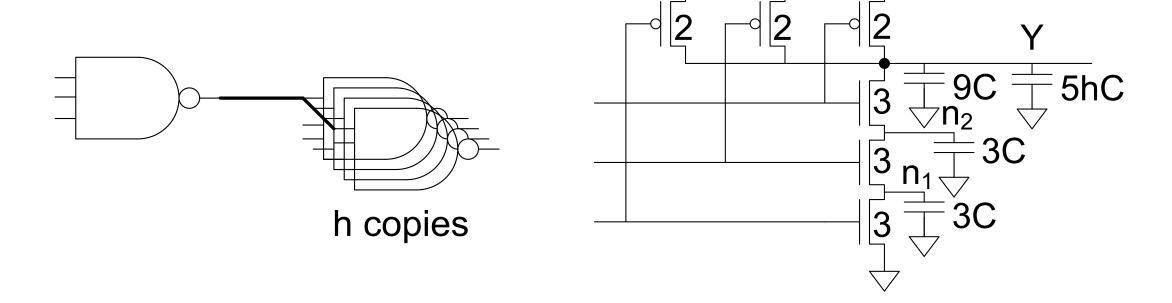
Homework#4

- Due: AM08:00, October 17
- Problem#1
 - -Consider a chain of two RC components. Assume that two resistors are the same and two capacitors are the same. At t=0, V_{in} suddenly changes from 1 V to 0 V.
 - Draw the exact response of V_{out} and an approximated one with a single time constant. R



4.3. RC delay model (9)

- Example 4.7 (*h* identical NANDs)
 - We studied it in Example 4.2.



4.3. RC delay model (10)

- For the falling transition
 - Estimate t_{pdf} .
- For the rising transition (in the worst case)
 - Estimate t_{pdr} .

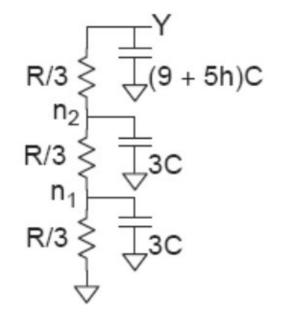
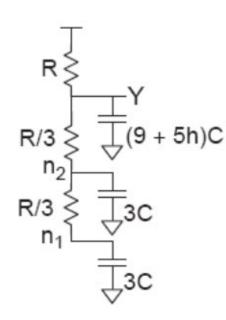


Fig. 4.15



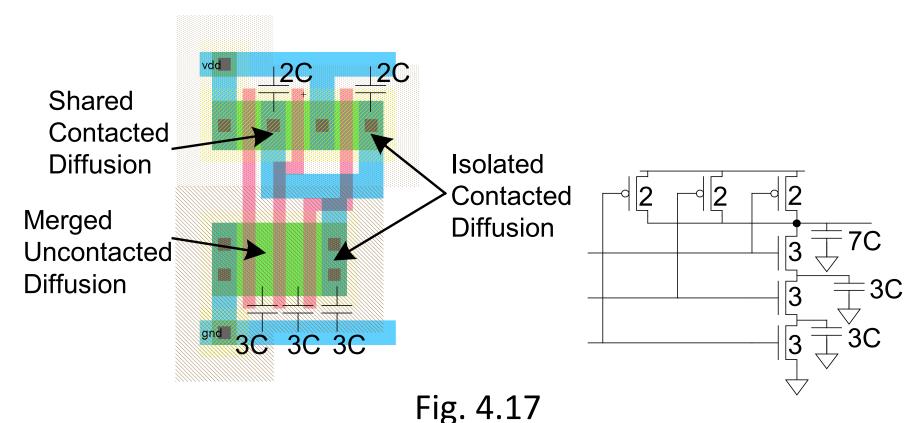
4.3. RC delay model (11)

- Delay components
 - Parastic delay: Time for a gate to drive its own internal diffusion capacitance
 - Effort delay: It depends on the ratio of external load capacitance to input capacitance.
 - -The normalized delay, $d = \frac{t_{pd}}{3RC}$, can be written as

d = parastic delay + effort delay

4.3. RC delay model (12)

- Layout dependence of capacitance
 - A good layout minimizes the diffusion area.



4.4 Linear Delay Model

4.4. Linear delay model (1)

- Delay in a logic gate
 - Normalized delay

$$d = \frac{t_{pd}}{3RC}$$

– Delay has two components:

$$d = f + p = gh + p$$

- Effort delay:

$$f = gh$$

(g is the logical effort.)

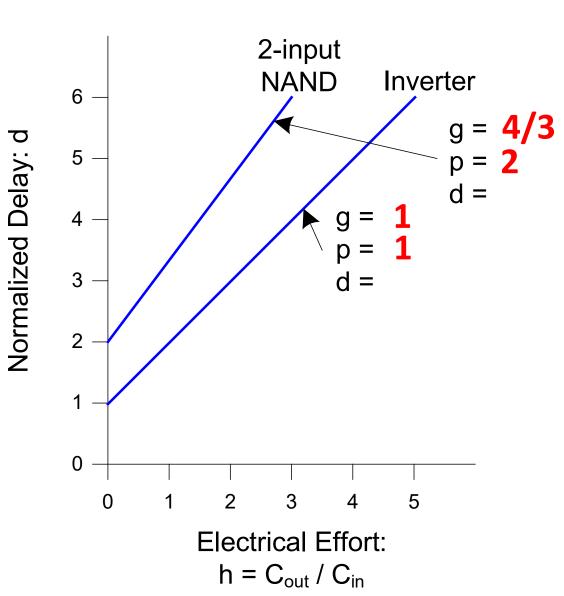
4.4. Linear delay model (2)

- Delay in a logic gate
 - Fanout (or electrical effort)

$$h = \frac{C_{out}}{C_{in}}$$

(Ratio of output to input capacitance)

- Parasitic delay, p, represents
 delay of gate driving no load.
- -p is set by internal parasitic capacitance.



Thank you!